1 -

AUG 0 9 2002

THE UNITED STATES PATENT AND TRADEMARK OFFICE

<u>.</u>

In re Patent Application of

Taiji NODA et al.) Group Art Unit: 2814
Serial No. 09/662,358) Examiner: Anh D. MAI

Filed: September 15, 2000

SEMICONDUCTOR DEVICE AND)

METHOD FOR FABRICATING THE SAME

AMENDMENT

Commissioner for Patents Washington, D.C. 20231

Sir:

For:

In response to the Examiner's non-final Office Action mailed February 11, 2002, the due date for which having been extended three months to August 11, 2002, please consider the following amendments and remarks in connection with the above-identified application.

IN THE CLAIMS:

Please cancel claims 16-19 without disclaimer or prejudice to the subject matter disclosed therein.

Please amend the claims as follows:

6. (Amended) A method for fabricating a semiconductor device that includes an extended high-concentration dopant diffused layer of a first conductivity and a pocket dopant diffused layer of a second conductivity, comprising:

a first step of forming a gate electrode over a semiconductor region with a gate insulating film interposed therebetween;

a second step of implanting heavy ions into the semiconductor region using the gate electrode as a mask, thereby forming a first ion implanted layer of the second conductivity, at least upper part of which is an amorphous layer;